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SON-2810

Appl. No. 10/647,217



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Patent Application of:
Yoshitaka Kayukawa et al.

Confirmation No.: 1901

Application No.: 10/647,217

Art Unit: 2811

Filed: August 26, 2003

Examiner: Violet McCoy

For: SEMICONDUCTOR INTEGRATED CIRCUIT
AND METHOD FOR TESTING SAME

SECOND STATUS INQUIRY

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Supplementing the Status Inquiry filed February 25, 2005, it is respectfully requested that the attorney named below be advised of the status of the above-identified application. Specifically, please advise us of when an initial Office Action on the merits may be expected from the Patent and Trademark Office. The application has now been pending approximately two years without an action on the merits.

Dated: September 22, 2005

Respectfully submitted,

By _____
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